Se	earch	Notes	

-	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/864,990	SEIBER, BRUCE A.
	Examiner	Art Unit
	Phillip Nguyen	2828

SEARCHED			
Class	Subclass	Date	Examiner
:			
	-		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
·				
:				
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
see the printout	11/10/2005	PN
•		